

No. 1 Workshop, M-10, Middle section, Science & Technology Park,

Shenzhen, Guangdong, China 518057

Telephone: +86 (0) 755 2601 2053 Report No.: SZEM180200138801 Fax: +86 (0) 755 2671 0594 Report No.: SZEM180200138801

Fax: +86 (0) 755 2671 0594 Page: 1 of 18

TEST REPORT

Application No.: SZEM1802001388RG

Applicant: Huawei Technologies Co.,Ltd

Address of Applicant: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,

Bantian, Longgang District Shenzhen China

Manufacturer: Huawei Technologies Co.,Ltd

Address of Manufacturer: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,

Bantian, Longgang District Shenzhen China

Equipment Under Test (EUT):

EUT Name: Smart Phone

Model No.: CLT-L09

FCC ID: QISCLT-L09

Standard(s): 47 CFR Part 15, Subpart E 15.407

Date of Receipt: 2018-02-10

Date of Test: 2018-02-12 to 2018-02-15

Date of Issue: 2018-02-22

Test Result: Pass*



EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

This document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at http://www.sgs.com/en/Terms-and-Conditions

^{*} In the configuration tested, the EUT complied with the standards specified above.



Report No.: SZEM180200138801

Page: 2 of 18

	Revision Record						
Version	Version Chapter Date Modifier Rem						
01		2018-02-22		Original			

Authorized for issue by:		
	Gray Gao	
	Gray Gao /Project Engineer	
	EvicFu	
	Eric Fu /Reviewer	-



Report No.: SZEM180200138801

Page: 3 of 18

2 Test Summary

Radio Spectrum Matter Part							
Item	Standard	Method	Requirement	Result			
DFS: Channel Move Time	47 CFR Part 15, Subpart E 15.407	KDB 905462 D02 Section 7.8.3	KDB 905462 D02 Section 5.1	Pass			
DFS: Channel Closing Transmission Time	47 CFR Part 15, Subpart E 15.407	KDB 905462 D02 Section 7.8.3	KDB 905462 D02 Section 5.1	Pass			

Remark:

This test report (Report No.: SZEM180200138801) is base on the original test report (Report No.:

SZEM180100021801)

According to the declaration from the applicant, the differences between CLT-L29 and CLT-L09 are as follows.

Model	CLT-L29	CLT-L09
Brand	the same	the same
Frequency	the same	the same
SIM Card	Dual SIM	Single SIM
Hardware Version	the same	the same
Software Version	Different	Different
Dimensions	the same	the same
Appearance	the same	the same
main antenna	the same	the same
BT/Wi-Fi antenna	the same	the same
div antenna	the same	the same

Therefore in this report all items do not need to retest and all the test data in this report are base on previous report with report number **SZEM180100021801**



Report No.: SZEM180200138801

Page: 4 of 18

3 Contents

			Page
1	COV	'ER PAGE	1
2	TES	T SUMMARY	3
3		ITENTS	
J	CON	ITENTS	4
4	GEN	IERAL INFORMATION	5
	4.1	DETAILS OF E.U.T.	5
	4.2	DESCRIPTION OF SUPPORT UNITS	5
	4.3	MEASUREMENT UNCERTAINTY	5
	4.4	TEST LOCATION.	
	4.5	TEST FACILITY	
	4.6	DEVIATION FROM STANDARDS	
	4.7	ABNORMALITIES FROM STANDARD CONDITIONS	
5	EQU	IIPMENT LIST	7
6	RΔD	NO SPECTRUM MATTER TEST RESULTS	8
Ŭ	61	DFS: CHANNEL MOVE TIME	
	0	DFS. CHANNEL MOVE TIME	
		2 Test Setup Diagram	
	6.1.3	· · ·	
	6.2	DFS: CHANNEL CLOSING TRANSMISSION TIME	
	6.2.1	E.U.T. Operation	
	6.2.2	Part Setup Diagram	
	6.2.3	Measurement Procedure and Data	15
7	APP	ENDIX	16
		A	4.0
	7.1	APPENDIX 15.407	In



Report No.: SZEM180200138801

Page: 5 of 18

4 General Information

4.1 Details of E.U.T.

Power supply:	DC 4.2V
---------------	---------

4.2 Description of Support Units

The EUT has been tested as an independent unit.

4.3 Measurement Uncertainty

No.	Item	Measurement Uncertainty
1	Radio Frequency	7.25 x 10-8
2	RF conducted power	0.75dB
3	Adjacent channel selectivity	±3 dB
4	Temperature test	1℃
5	Humidity test	3%
6	Supply voltages	1.5%



Report No.: SZEM180200138801

Page: 6 of 18

4.4 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

4.5 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

• A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• FCC -Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

4.6 Deviation from Standards

None

4.7 Abnormalities from Standard Conditions

None



Report No.: SZEM180200138801

Page: 7 of 18

5 Equipment List

	RF test system						
Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Date (yyyy-mm-dd)	Cal. Due date (yyyy-mm-dd)	
1	EXA Signal Analyzer (10Hz- 44GHz)	KEYSIGHT	N9010A	SEM004-12	2017-07-17	2018-07-16	
2	Signal Generator(9kHz- 3GHz)	KEYSIGHT	N5171B	SEM006-13	2017-07-17	2018-07-16	
3	MXG Vector Signal Generator	KEYSIGHT	N5182A	SEM006-14	2017-06-05	2018-06-04	
4	DC Power Supply	KEYSIGHT	E3642A	SEM011-07	2017-06-05	2018-06-04	
5	Manual Step Attenuator	KEYSIGHT	8494B	SEM021-05	2017-07-17	2018-07-16	
6	Manual Step Attenuator	KEYSIGHT	8496B	SEM021-06	2017-07-17	2018-07-16	
7	Power Sensor	KEYSIGHT	U2021XA	SEM009-13	2017-03-25	2018-03-24	
8	Power Sensor	KEYSIGHT	U2021XA	SEM009-14	2017-03-23	2018-03-22	
9	Power Sensor	KEYSIGHT	U2021XA	SEM009-15	2017-04-04	2018-04-03	
10	Power Sensor	KEYSIGHT	U2021XA	SEM009-16	2017-03-20	2018-03-19	
11	Bluetooth Tester	Rohde & Schwarz	CBT	W060-01	2017-06-21	2018-06-20	
12	Universal Radio Communication Tester	Rohde & Schwarz	CMW 500	SEM010-03	2017-04-14	2018-04-13	
13	Measurement Software	JS Tonscend	JS1120-2 BT/WIFI V2.6	N/A	N/A	N/A	
14	Coaxial Cable	SGS	N/A	SEM028-01	2017-07-13	2018-07-12	

General used equipment						
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date	
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-03	2017-09-29	2018-09-28	
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-04	2017-09-29	2018-09-28	
Humidity/ Temperature Indicator	Mingle	N/A	SEM002-08	2017-09-29	2018-09-28	
Barometer	Changchun Meteorological Industry Factory	DYM3	SEM002-01	2017-04-18	2018-04-17	



Report No.: SZEM180200138801

Page: 8 of 18

6 Radio Spectrum Matter Test Results

6.1 DFS: Channel Move Time

Test Requirement KDB 905462 D02 Section 5.1
Test Method: KDB 905462 D02 Section 7.8.3

Limit: 10 seconds(should be performed with Radar Type 0. The measurement

timing begins at the end of the Radar Type 0 burst)



Report No.: SZEM180200138801

Page: 9 of 18

6.1.1 E.U.T. Operation

Operating Environment:

Temperature: 22.4 °C Humidity: 42.7 % RH Atmospheric Pressure: 1020 mbar

Pretest these b:TX mode (Band 2A) mode to find the c:TX mode (Band 2C).

worst case:

The worst case b:TX mode (Band 2A) for final test: c:TX mode (Band 2C).



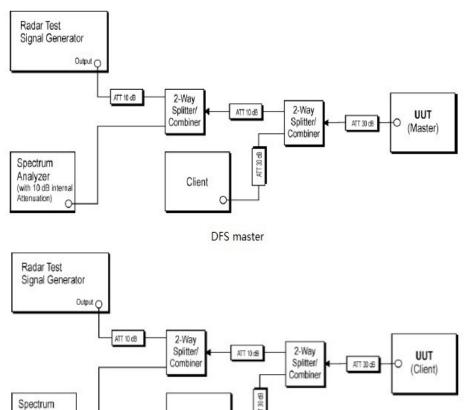
Report No.: SZEM180200138801

Page: 10 of 18

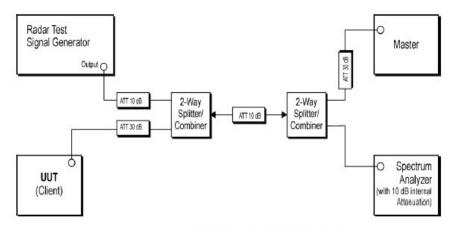
6.1.2 Test Setup Diagram

Analyzer

(with 10 dB internal Attenuation)



DFS slave with radar detection



Master

DFS slave without radar detection



Report No.: SZEM180200138801

Page: 11 of 18

6.1.3 Measurement Procedure and Data

- 1) The radar pulse generator is setup to provide a pulse at frequency that the master and client are operating. A type 0 radar pulse with a 1us pulse width and a 1428us PRI is used for the testing.
- 2) The vector signal generator is adjusted to provide the radar burst (18 pulses) at the level of approximately -61dBm at the antenna port of the master device.
- 3) A trigger is provided from the pulse generator to the DFS monitoring system in order to capture the traffic and the occurrence of the radar pulse.
- 4) EUT will associate with the master at channel. The file "iperf.exe" specified by the FCC is streamed from the PC 2 through the master and the client device to the PC 1 and played in full motion video using Media Player Classic Ver. 6.4.8.6 in order to properly load the network for the entire period of the test
- 5) When radar burst with a level equal to the DFS Detection Threshold +1dB is generated on the operating channel of the U-NII device. At time T0 the radar waveform generator sends a burst of pulse of the radar waveform at Detection Threshold +1dB.
- 6) Observe the transmissions of the EUT at the end of the radar Burst on the Operating Channel. Measure and record the transmissions from the UUT during the observation time (Channel Move Time). One 15 seconds plot is reported for the Short Pulse Radar Type 0. The plot for the Short Pulse Radar Types start at the end of the radar burst. The Channel Move Time will be calculated based on the zoom in 600ms plot of the Short Pulse Radar Type.
- 7) Measurement of the aggregate duration of the Channel Closed Transmission Time method. With the spectrum analyzer set to zero span tuned to the center frequency of the EUT operating channel at the radar simulated frequency, peak detection, and max hold, the dwell time per bin is given by: Dwell (0.3ms) =S (12000ms) / B (4000); where Dwell is the dwell time per spectrum analyzer sampling bin, S is sweep time and B is the number of spectrum analyzer sampling bins. An upper bound of the aggregate duration of the intermittent control signals of Channel Closing Transmission Time is calculated by: C (ms)= N X Dwell (0.3ms); where C is the Closing Time, N is the number of spectrum analyzer sampling bins (intermittent control signals) showing a U-NII transmission and Dwell is the dwell time per bin.
- 8) Measurement the EUT for more than 30 minutes following the channel move time to verify that no transmission or beacons occur on this channel.

The detailed test data see: Appendix 15.407



Report No.: SZEM180200138801

Page: 12 of 18

6.2 DFS: Channel Closing Transmission Time

Test Requirement KDB 905462 D02 Section 5.1
Test Method: KDB 905462 D02 Section 7.8.3

Limit: 200 milliseconds + an aggregate of 60 milliseconds over remaining 10

second period(should be performed with Radar Type 0. The measurement timing begins at the end of the Radar Type 0 burst. It is comprised of 200 milliseconds starting at the beginning of the Channel Move Time plus any additional intermittent control signals required facilitating a Channel move (an aggregate of 60 milliseconds) during the remainder of the 10 second period. The aggregate duration of control signals will not count quiet periods

in between transmissions)



Report No.: SZEM180200138801

Page: 13 of 18

6.2.1 E.U.T. Operation

Operating Environment:

Temperature: 22.4 °C Humidity: 42.7 % RH Atmospheric Pressure: 1020 mbar

Pretest these b:TX mode (Band 2A) mode to find the c:TX mode (Band 2C).

worst case:

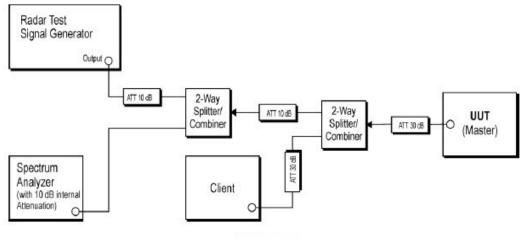
The worst case b:TX mode (Band 2A) for final test: c:TX mode (Band 2C).



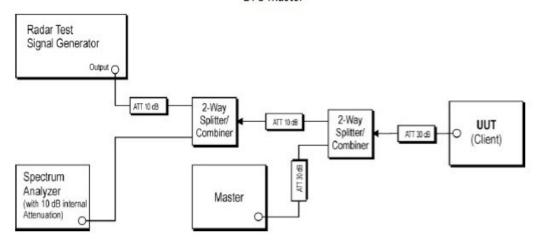
Report No.: SZEM180200138801

Page: 14 of 18

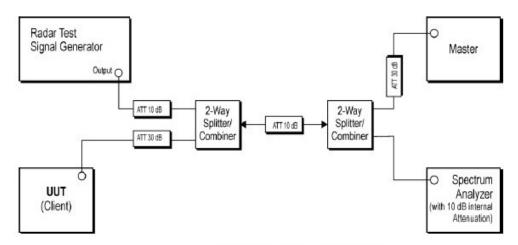
6.2.2 Test Setup Diagram



DFS master



DFS slave with radar detection



DFS slave without radar detection



Report No.: SZEM180200138801

Page: 15 of 18

6.2.3 Measurement Procedure and Data

- 1) The radar pulse generator is setup to provide a pulse at frequency that the master and client are operating. A type 0 radar pulse with a 1us pulse width and a 1428us PRI is used for the testing.
- 2) The vector signal generator is adjusted to provide the radar burst (18 pulses) at the level of approximately -61dBm at the antenna port of the master device.
- 3) A trigger is provided from the pulse generator to the DFS monitoring system in order to capture the traffic and the occurrence of the radar pulse.
- 4) EUT will associate with the master at channel. The file "iperf.exe" specified by the FCC is streamed from the PC 2 through the master and the client device to the PC 1 and played in full motion video using Media Player Classic Ver. 6.4.8.6 in order to properly load the network for the entire period of the test
- 5) When radar burst with a level equal to the DFS Detection Threshold +1dB is generated on the operating channel of the U-NII device. At time T0 the radar waveform generator sends a burst of pulse of the radar waveform at Detection Threshold +1dB.
- 6) Observe the transmissions of the EUT at the end of the radar Burst on the Operating Channel. Measure and record the transmissions from the UUT during the observation time (Channel Move Time). One 15 seconds plot is reported for the Short Pulse Radar Type 0. The plot for the Short Pulse Radar Types start at the end of the radar burst. The Channel Move Time will be calculated based on the zoom in 600ms plot of the Short Pulse Radar Type.
- 7) Measurement of the aggregate duration of the Channel Closed Transmission Time method. With the spectrum analyzer set to zero span tuned to the center frequency of the EUT operating channel at the radar simulated frequency, peak detection, and max hold, the dwell time per bin is given by: Dwell (0.3ms) =S (12000ms) / B (4000); where Dwell is the dwell time per spectrum analyzer sampling bin, S is sweep time and B is the number of spectrum analyzer sampling bins. An upper bound of the aggregate duration of the intermittent control signals of Channel Closing Transmission Time is calculated by: C (ms)= N X Dwell (0.3ms); where C is the Closing Time, N is the number of spectrum analyzer sampling bins (intermittent control signals) showing a U-NII transmission and Dwell is the dwell time per bin.
- 8) Measurement the EUT for more than 30 minutes following the channel move time to verify that no transmission or beacons occur on this channel.

The detailed test data see: Appendix 15.407

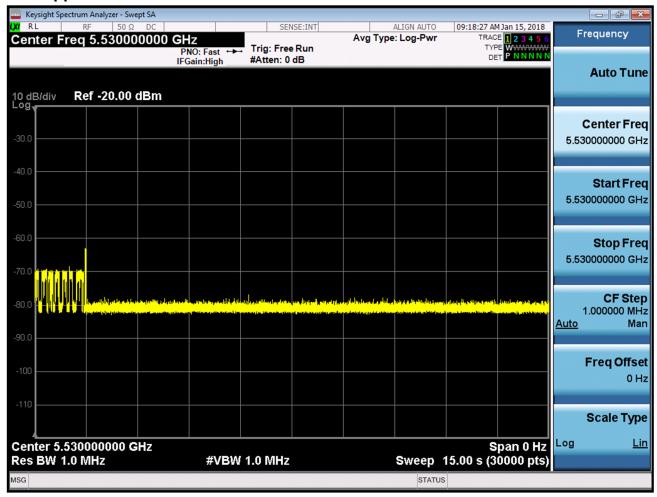


Report No.: SZEM180200138801

Page: 16 of 18

7 Appendix

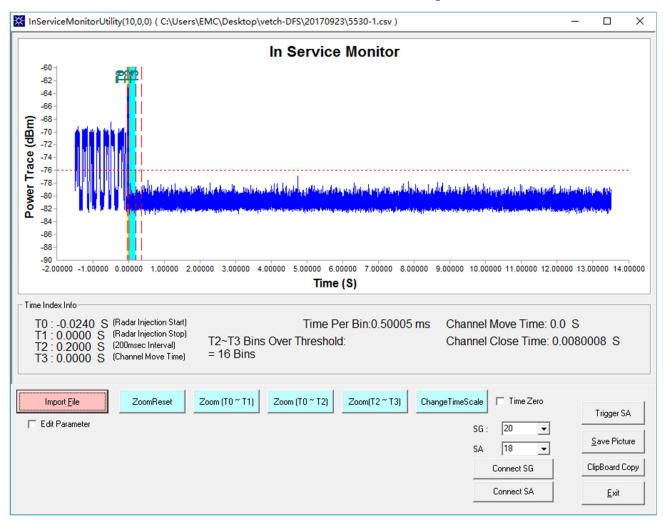
7.1 Appendix 15.407





Report No.: SZEM180200138801

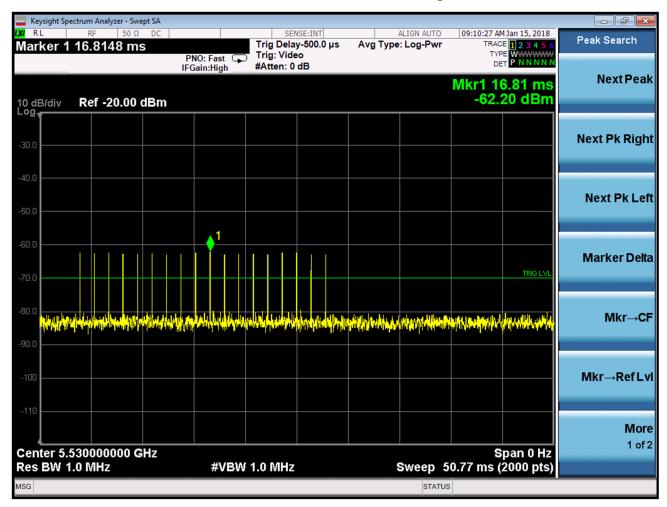
Page: 17 of 18





Report No.: SZEM180200138801

Page: 18 of 18



- End of the Report -